

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

LIU ET AL.

Examiner

BRIAN D. NGUYEN

Art Unit

2416

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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-2004/0001579	01-2004	Feinberg et al.	379/156
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
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**FOREIGN PATENT DOCUMENTS**

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